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STATEMENT BY APPLICANT**

(Not for submission under 37 CFR 1.99)



Application Number		10766779
Filing Date		2004-01-27
First Named Inventor	McCallister, Ronald D.	
Art Unit	2611	
Examiner Name	BAYARD, Emmanuel	
Attorney Docket Number	2298-020	

U.S. PATENTS

Examiner Initial*	Cite No	Patent Number	Kind Code ¹	Issue Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
/E.B./	1	6515712	B1	2003-02-04	Jeong	
/E.B./	2	6600516	B1	2003-07-29	Danielsons, et al.	
/E.B./	3	6281936	B1	2001-08-28	Twitchell, et al.	
/E.B./	4	6775330	B2	2004-08-10	Bach, et al.	
/E.B./	5	6335767	B1	2002-01-01	Twitchell, et al.	
/E.B./	6	5903823	A	1999-05-11	Moriyama, et al.	
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/E.B./	9	5819165	A	1998-10-06	Hulkko, et al.	
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/E.B./	1	20050123066	A1	2005-06-09	Sarca	
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/E.B./	1	1318643	EP	A	2003-11-06	Ericsson		<input type="checkbox"/>

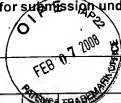
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/E.B./	1	MORGAN, MA, DING, "Reducing Measurement Noise Effects in Digital Predistortion of RF Power Amplifiers", Bell Laboratories, IEEE 2003.	<input type="checkbox"/>
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/E.B./	8	IBANEZ-DIAZ, PANTALEON, SANTAMARIA, FERNANDEZ, MARTINEZ, "Nonlinear Estimation in Power Amplifiers Based on Subsampled Temporal Data", IEEE 2001	<input type="checkbox"/>
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/E.B./	10	DANSHRAD "DSP VLSI Engine for Electronic Linearization of Fiber Optic Links" Wireless Integrated Systems Research Group, UCLA, 02/27/2001.	<input type="checkbox"/>

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Examiner Signature	/Emmanuel Bayard/	Date Considered	05/14/2008
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